

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SUGITA ET AL.	
		Examiner Dah-Wei D. Yuan	Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,096,450	08-2000	Walsh, Michael M.	429/34
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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